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Characterisation of HEXITEC MHz –a 1 MHz continuous frame rate spectroscopic X-ray imaging detector system

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The HEXITEC_{*MHz*} detector system is the latest generation of the STFC's HEXITEC spectroscopic X-ray imaging detector systems. When coupled to Cd(Zn)Te sensor material, the original HEXITEC system delivers high-resolution X-ray spectroscopy (50 electrons RMS) per 250 µm pitch pixel for hard X-rays with energies 2 - 200 keV. However, a 9.1 kHz frame rate and the need to identify charge-sharing events limits its application to photon fluxes of $^{10^4}$ ph s⁻¹ mm⁻². With many photon light sources undergoing major upgrades to diffraction-limited storage rings, these expected increases in flux have motivated the development of the next generation of the HEXITEC technology. This demand has also been driven by spectroscopic X-ray imaging techniques such as Hyperspectral X-ray Tomography, which require operation under a high incident X-ray flux for time-resolved measurements.

The HEXITEC_{*MHz*} system is targeted at delivering the same high-resolution spectroscopy as the original ASIC whilst targeting higher photon fluxes. Whilst the ASIC maintains the same 250 µm pixel pitch, the new integrating Front End architecture, in-pixel digitisation and high-speed serialisers deliver a 1 MHz frame rate. This enables operation at fluxes of >10⁶ ph s⁻¹ mm⁻² for spectroscopic X-ray imaging applications.

A 300 µm thick p-type Si HEXITEC_{*MHz*} detector was characterised on the B16 Test Beamline at the Diamond Light Source and are the first measurements taken at a 1 MHz frame rate. At 10 keV and 15 keV the device displayed average FWHM of 656 eV and 682 eV respectively, with minimal changes in spectroscopic performance over ^{*}8 h. Analysis of charge-sharing events show low charge loss and a linear energy-signal response. Higher-flux measurements illustrated the capability of HEXITEC_{*MHz*} to operate as a photon-counting device, capable of measuring 30 × 10 keV photons in a single frame. Results from a high-flux CdZnTe device will also be shown.

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